Title: Datasheet for CD4069UB Customer Contact: PCN Manager Dept: Quality Services Change Type: Assembly Site Design Wafer Bump Material Assembly Process Data Sheet Wafer Bump Material Assembly Process Wafer Bump Material Assembly Materials Park Inumber change Wafer Bump Process Mechanical Specification Test Site Wafer Fab Site Packing/Shipping/Labeling Test Process Wafer Fab Materials Notification Details Pescription of Change: Texas Instruments Incorporated is announcing an information only notification. The product datasheet(s) is being updated as summarized below. The following change history provides further details. TEXAS INSTRUMENTS CD4069UB Changes from Revision D (February 2016) to Revision E Page Removed artifact "-" at t _{Dest.} term on the second Features bullet 1 Corrected y, spec MINMAX values in the Abs Max Ratings table 4 Corrected parameter log max term to log in the Elec Characteristics table 5 Corrected parameter log max term to log in the Elec Characteristics table 5 Corrected parameter V _t max term to V _t in the Elec Characteristics table 6 Corrected parameter V _t max term to V _t in the Elec Characteristics table 6 Corrected parameter V _t max term to V _t in the Elec Characteristics table 6 Corrected parameter V _t max term to V _t in the Elec Characteristics table 6 Corrected parameter V _t max term to V _t in the Elec Characteristics table 6 Corrected parameter V _t max term to V _t in the Elec Characteristics table 6 Corrected parameter V _t max term to V _t in the Elec Characteristics table 6 Corrected parameter V _t min term to V _t in the Elec Characteristics table 7 Added Y-axis table to Figure 1 image object 8 Characteristics table 7 Added Y-axis table to Figure 1 image object 8 Characteristics table 7 Change From: Change To: CD4069UB 8 CHange From: Change To: CD4069UB 8 CHange From: Change To: CD4069UB 9 Change From: Change To: CD4069UB 9 Change From: Change To: CD4069UB 9 Change From: Change To: Change For Change From: Change To: Change For Change From: Change To: C			
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the actual device.			
Changes to product identification resulting from this PCN:			
None.			
Product Affected:			
CD4069UBE CD4069UBEE4 CD4069UBF CD4069UBF3A			
CD4069UBM CD4069UBM96 CD4069UBMT CD4069UBNSR			
CD4069UBPW CD4069UBPWG4 CD4069UBPWR JM38510/17401BCA			
M38510/17401BCA			

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

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